Application/Control No. Applicant(s)/Patent Under Reexamination 10/624,489 VIERICH ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Shew-Fen Lin 2166 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification MM-YYYY Country Code-Number-Kind Code US-6,569,205 B1 05-2003 Poggi, Valerie S. Α 715/500 US-2003/0208460 A1 11-2003 В Srikant et al. 707/1 10-2004 US-6,801,910 B1 Bedell et al. С 707/6 D US-6,807,518 B1 10-2004 Lang, Theodore James 703/2 US-Ε F US-G US-US-US-1 US-J Κ US-US-L М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.